



PRODUCT DATA SHEET



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Datasheet Resou

Sample

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



20V N-Channel Enhancement Mode Power MOSFET

FEATURES

Power MOSFET: 1.8-V RatedGate-Source ESD Protected

High-Side SwitchingLow On-Resistance: 0.4Ω

Low Threshold: 0.8 V (typ)Fast Switching Speed: 10 ns

 We declare that the material of product compliance with RoHS requirements and Halogen Free.

 S- prefix for automotive and other applications requiring unique site and control change requirements; AEC-Q101 qualified and PPAP capable.

BENEFITS

- Ease in Driving Switches
- Low Offset (Error) Voltage
- Low-Voltage Operation
- High-Speed Circuits
- Low Battery Voltage Operation

APPLICATIONS

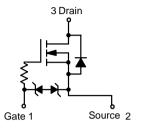
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories.
- Battery Operated Systems
- Power Supply Converter Circuits
- Load/Power Switching Cell Phones, Pagers

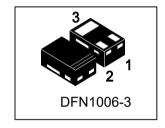
MAXIMUM RATINGS(Ta = 25℃)

Parameter		Symbol	5 secs	Steady State	Unit	
Drain-Source Voltage		VDS	20		V	
Gate-Source Voltage		VGS	±8		V	
Continuous Drain Current (TJ = 150°C)	TA = 25℃	ID	600	500		
(Note 2)	TA = 85℃	l ID	400	350	mA	
Pulsed Drain Current(Note 1)		IDM	1000		IIIA	
Continuous Source Current (diode conduction)(Note 2)		IS	275	250		
Maximum Power Dissipation(Note 2)		PD		250	mW	
Thermal Resistance, Junction to Ambient		RθJA		500	°C/W	
Operating Junction and Storage Temperature Range		TJ , Tstg	− 55 ~+150		$^{\circ}$	

^{1.} Pulse width limited by maximum junction temperature.

2.Surface Mounted on FR4 Board.







ELECTRICAL CHARACTERISTICS (Ta= 25°C)

Static

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Gate Threshold Voltage	VGS(th)				V
(VDS = VGS , ID = 250μA)	VOO(iii)	0.35	-	1.0	v
Gate-Body Leakage	IGSS				пΛ
$(VDS = 0 V, VGS = \pm 4.5 V)$	1033	-	±0.5	±1	μΑ
Zero Gate Voltage Drain Current					
(VDS = 20 V, VGS = 0 V)	IDSS	-	0.3	100	nA
(VDS = 20 V, VGS = 0 V, TJ = 85℃)		-	-	5	μΑ
On-State Drain Current(Note 1)	ID(on)				A
(VDS = 5 V, VGS = 4.5 V)	10(01)	700	-	-	mA
Drain-Source On-State Resistance(Note 1)					
(VGS = 4.5 V, ID = 500 mA)	RDS(on)		0.25	0.4	Ω
(VGS = 2.5 V, ID = 500 mA)	KD3(011)		0.3	0.5	12
(VGS = 1.8 V, ID = 350 mA)			0.5	0.7	
Forward Transconductance(Note 1)	ofo				S
(VDS = 10 V, ID = 400 mA)	gfs		1		3
Diode Forward Voltage(Note 1)	VSD				V
(IS = 150 mA, VGS = 0 V)	VSD		0.8	1.2	V

Dynamic(Note 2)

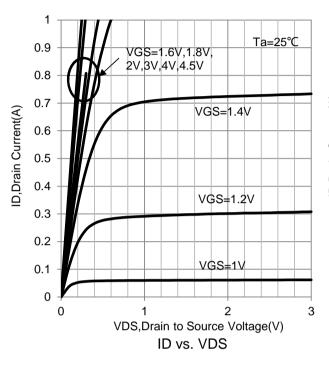
,				
Total Gate Charge	(VDS = 10 V,	Qg	750	
Gate-Source Charge	VGS = 4.5 V, ID	Qgs	75	рС
Gate-Drain Charge	= 250 mA)	Qgd	225	
Turn-On Delay Time	(VDD = 10 V, RL	td(on)	5	
Rise Time	= 47Ω,ID=200 mA, VGEN = 4.5	tr	5	ne
Turn-Off Delay Time		td(off)	25	ns
Fall Time	V, RG = 10Ω)	tf	11	*

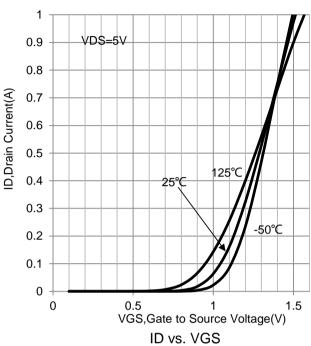
^{3.} Pulse test; pulse width \leq 300 µs, duty cycle \leq 2%.

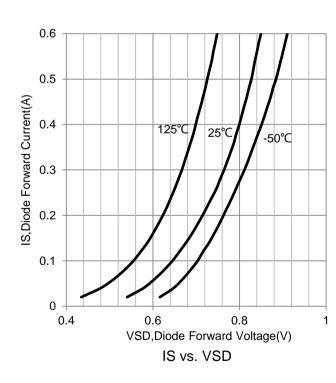
^{4.} Guaranteed by design, not subject to production testing.

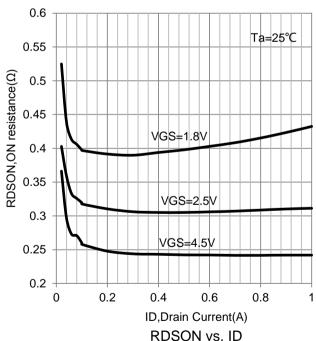


ELECTRICAL CHARACTERISTICS CURVES

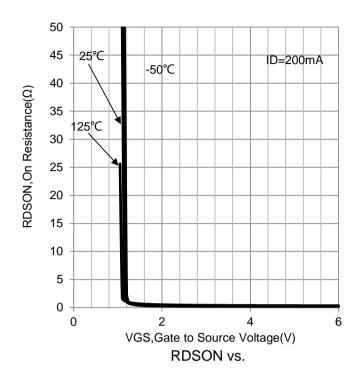


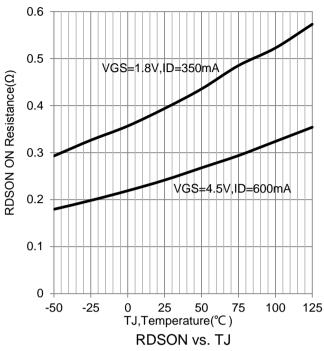


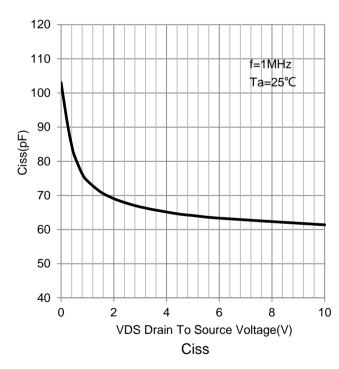


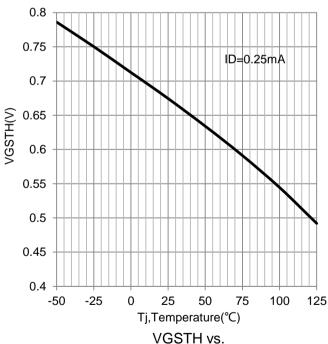






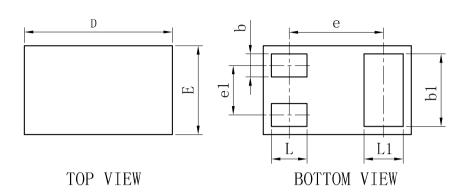




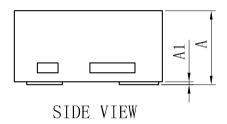




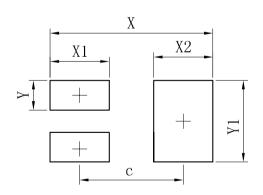
OUTLINE AND DIMENSIONS



SOT883				
DIM	MIN	TYP	MAX	
D	0.95	1.00	1.05	
Е	0.55	0.60	0.65	
е	-	0.64	-	
e1	ı	0.34	-	
L	0.19	0.24	0.29	
L1	0.22	0.27	0.32	
b	0.10	0.15	0.20	
b1	0.44	0.49	0.54	
Α	0.43	0.48	0.53	
A1	0	-	0.05	
All Dimensions in mm				



SOLDERING FOOTPRINT



Dimensions	(mm)		
С	0.70		
X	1.10		
X1	0.40		
X2	0.40		
Υ	0.20		
Y1	0.55		



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